Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/625,157	BENDETT ET AL.
Examiner	Art Unit
Ahmed M. Farah	3735

SEARCHED					
Class	Subclass	Date	Examiner		
606	3-6, 8-12, 166	8/30/2007	AF		
607	88-92	8/30/2007	45		
128	898	8/30/2007	AF.		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		
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Interference Search History Printout.		8/30/2007	Ar	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Search; and EAST search: Classification (IS&R); and Text (BRS)	8/30/2007	AF		
Searched Data Basis: USPAT; USPGPUB; EPO; JPO; DERWENT; and IBM_TDB.	8/30/2007	AR		
See the attached "Search History."	8/30/2007	AF		